



# SK04N100B-TF

## 1000V N-ch Planar MOSFET

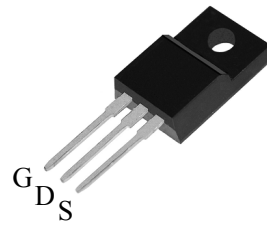
### General Features

- RoHS Compliant
- $R_{DS(ON),typ.}=2.2\ \Omega @ V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

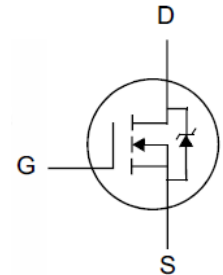
### Applications

- Adaptor
- Charger
- SMPS Standby Power

| $BV_{DSS}$ | $R_{DS(ON),typ.}$ | $I_D$ |
|------------|-------------------|-------|
| 1000V      | $2.2\ \Omega$     | 4.0A  |



TO-220F



Package No to Scale

### Absolute Maximum Ratings

$T_C=25^\circ\text{C}$  unless otherwise specified

| Symbol           | Parameter                                                           | SK04N100B-TF | Unit               |
|------------------|---------------------------------------------------------------------|--------------|--------------------|
| $V_{DSS}$        | Drain-to-Source Voltage                                             | 1000         | V                  |
| $V_{GSS}$        | Gate-to-Source Voltage                                              | $\pm 30$     |                    |
| $I_D$            | Continuous Drain Current                                            | 4.0          | A                  |
| $I_{DM}$         | Pulsed Drain Current at $V_{GS}=10V$                                | 16           |                    |
| $E_{AS}$         | Single Pulse Avalanche Energy                                       | 450          | mJ                 |
| $E_{AR}$         | Repetitive Avalanche Energy                                         | 12           |                    |
| $P_D$            | Power Dissipation                                                   | 33           | W                  |
|                  | Derating Factor above $25^\circ\text{C}$                            | 0.26         | $W/^\circ\text{C}$ |
| $T_L$            | Soldering Temperature<br>Distance of 1.6mm from case for 10 seconds | 300          | $^\circ\text{C}$   |
| $T_J \& T_{STG}$ | Operating and Storage Temperature Range                             | -55 to 150   |                    |

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

### Thermal Characteristics

| Symbol          | Parameter                               | SK04N100B-TF | Unit               |
|-----------------|-----------------------------------------|--------------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | 3.78         | $^\circ\text{C}/W$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 100          |                    |



# SK04N100B-TF

## Electrical Characteristics

### OFF Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

| Symbol     | Parameter                         | Min. | Typ. | Max. | Unit    | Test Conditions                                          |
|------------|-----------------------------------|------|------|------|---------|----------------------------------------------------------|
| $BV_{DSS}$ | Drain-to-Source Breakdown Voltage | 1000 | --   | --   | V       | $V_{GS}=0V$ , $I_D=250\mu A$                             |
| $I_{DSS}$  | Drain-to-Source Leakage Current   | --   | --   | 1    | $\mu A$ | $V_{DS}=1000V$ , $V_{GS}=0V$                             |
|            |                                   | --   | --   | 100  |         | $V_{DS}=800V$ , $V_{GS}=0V$ ,<br>$T_J=125^\circ\text{C}$ |
| $I_{GSS}$  | Gate-to-Source Leakage Current    | --   | --   | +100 | nA      | $V_{GS}=+30V$ , $V_{DS}=0V$                              |
|            |                                   | --   | --   | -100 |         | $V_{GS}=-30V$ , $V_{DS}=0V$                              |

### ON Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

| Symbol       | Parameter                            | Min. | Typ. | Max. | Unit     | Test Conditions                  |
|--------------|--------------------------------------|------|------|------|----------|----------------------------------|
| $R_{DS(ON)}$ | Static Drain-to-Source On-Resistance | --   | 2.2  | 2.5  | $\Omega$ | $V_{GS}=10V$ , $I_D=2A$          |
| $V_{GS(TH)}$ | Gate Threshold Voltage               | 3.0  | --   | 5.0  | V        | $V_{DS}=V_{GS}$ , $I_D=250\mu A$ |
| gfs          | Forward Transconductance             | --   | 4.5  | --   | S        | $V_{DS}=15V$ , $I_D=2A$          |

### Dynamic Characteristics

Essentially independent of operating temperature

| Symbol    | Parameter                     | Min. | Typ. | Max. | Unit | Test Conditions                                      |
|-----------|-------------------------------|------|------|------|------|------------------------------------------------------|
| $C_{iss}$ | Input Capacitance             | --   | 1470 | --   | pF   | $V_{GS}=0V$ ,<br>$V_{DS}=25V$ ,<br>$f=1.0\text{MHz}$ |
| $C_{rss}$ | Reverse Transfer Capacitance  | --   | 21   | --   |      |                                                      |
| $C_{oss}$ | Output Capacitance            | --   | 115  | --   |      |                                                      |
| $Q_g$     | Total Gate Charge             | --   | 36   | --   | nC   | $V_{DD}=500V$ ,<br>$I_D=4A$ , $V_{GS}=0$ to $10V$    |
| $Q_{gs}$  | Gate-to-Source Charge         | --   | 7.5  | --   |      |                                                      |
| $Q_{gd}$  | Gate-to-Drain (Miller) Charge | --   | 14   | --   |      |                                                      |

### Resistive Switching Characteristics

Essentially independent of operating temperature

| Symbol       | Parameter           | Min. | Typ. | Max. | Unit | Test Conditions                                                  |
|--------------|---------------------|------|------|------|------|------------------------------------------------------------------|
| $t_{d(ON)}$  | Turn-on Delay Time  | --   | 20   | --   | nS   | $V_{DD}=500V$ ,<br>$I_D=4A$ ,<br>$V_{GS}=10V$<br>$R_g=4.7\Omega$ |
| $t_{rise}$   | Rise Time           | --   | 23   | --   |      |                                                                  |
| $t_{d(OFF)}$ | Turn-Off Delay Time | --   | 28   | --   |      |                                                                  |
| $t_{fall}$   | Fall Time           | --   | 26   | --   |      |                                                                  |



# SK04N100B-TF

## Source-Drain Body Diode Characteristics

$T_J=25^{\circ}\text{C}$  unless otherwise specified

| Symbol   | Parameter                                | Min | Typ. | Max. | Unit | Test Conditions                                                   |
|----------|------------------------------------------|-----|------|------|------|-------------------------------------------------------------------|
| $I_{SD}$ | Continuous Source Current <sup>[2]</sup> | --  | --   | 4    | A    | Integral pn-diode<br>in MOSFET                                    |
| $I_{SM}$ | Pulsed Source Current <sup>[2]</sup>     | --  | --   | 16   |      |                                                                   |
| $V_{SD}$ | Diode Forward Voltage                    | --  | --   | 1.5  | V    | $I_S=4\text{A}$ , $V_{GS}=0\text{V}$                              |
| $t_{rr}$ | Reverse Recovery Time                    | --  | 320  | --   | ns   | $V_{GS}=0\text{V}$<br>$I_F=I_S$ , $di/dt=100\text{A}/\mu\text{s}$ |
| $Q_{rr}$ | Reverse Recovery Charge                  | --  | 1.00 | --   | uC   |                                                                   |

### Note:

[1]  $T_J=+25^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$

[2] Pulse width $\leq 380\mu\text{s}$ ; duty cycles $\leq 2\%$ .

## Typical Characteristics

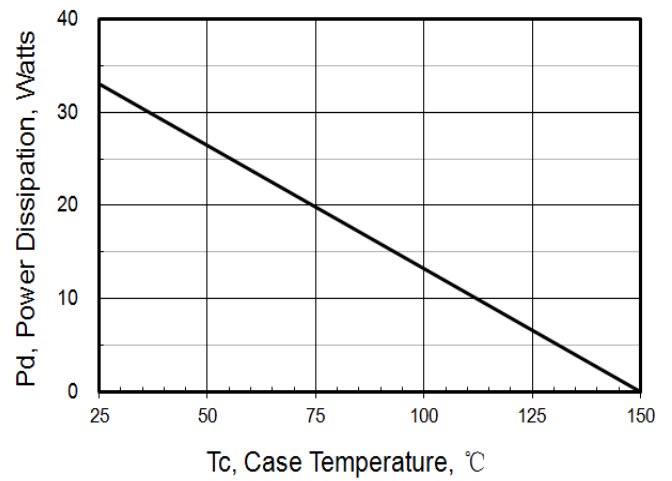
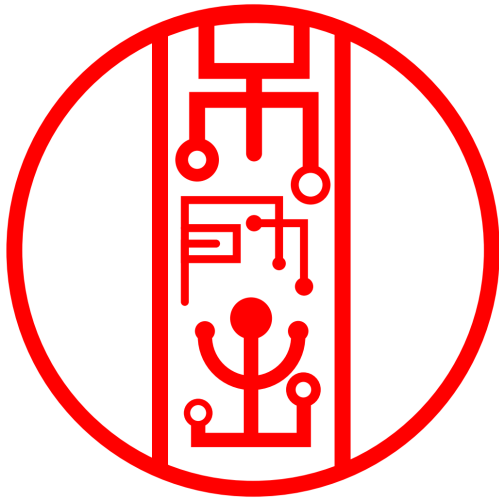


Figure 2 . Maximum Power Dissipation vs Tc

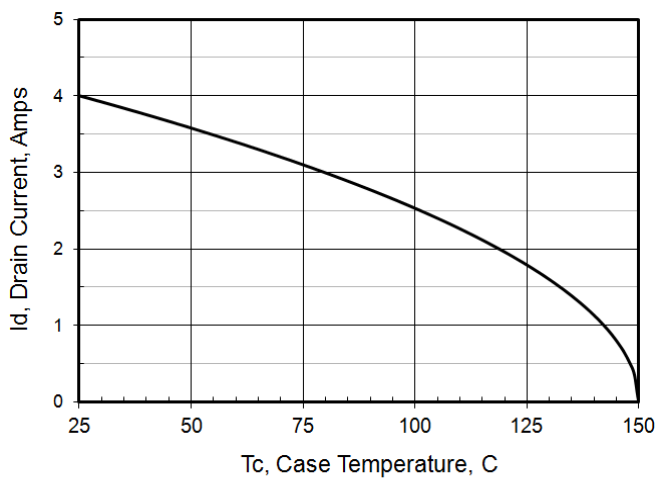


Figure 3 .Id vs Case Temperature

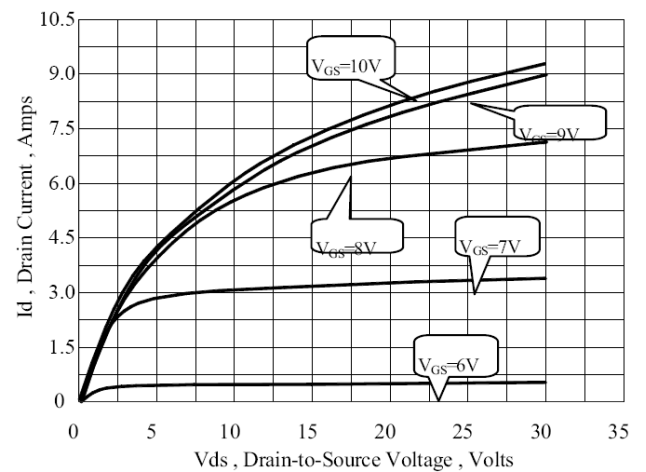


Figure 4 Typical Output Characteristics

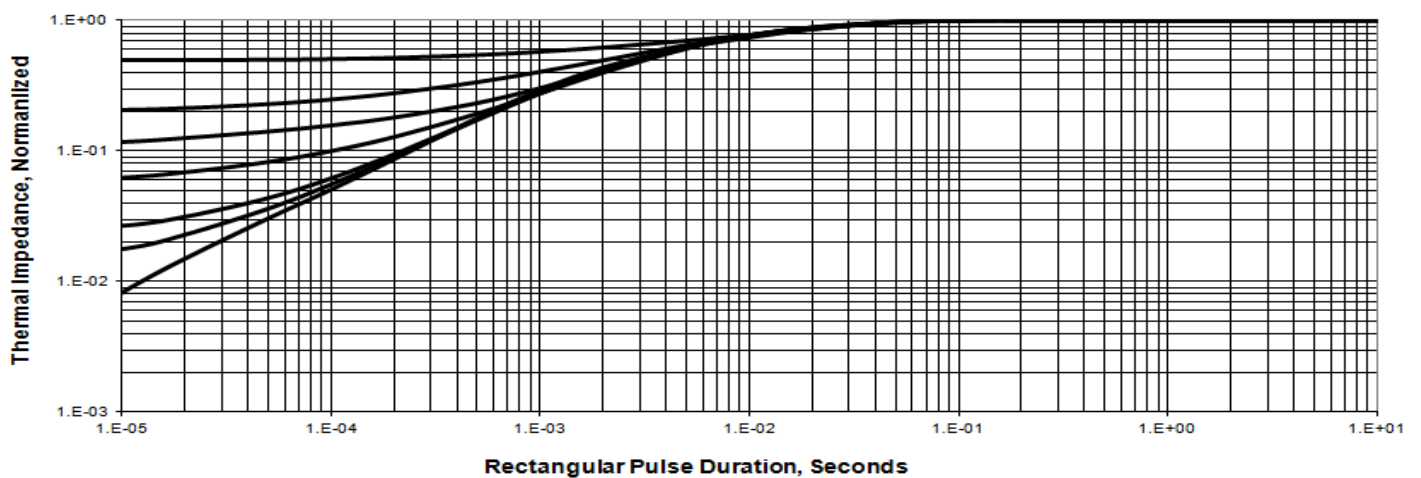


Figure 5. Maximum Transient Thermal Impedance

## Typical Characteristics(Cont.)

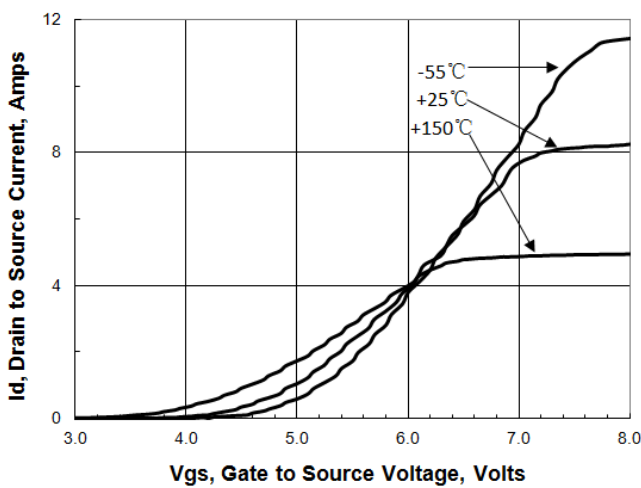
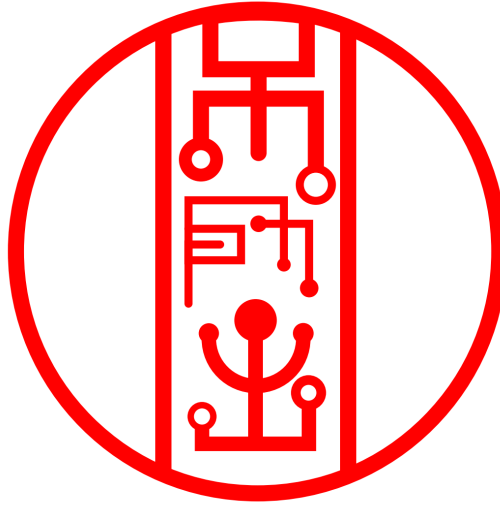


Figure 7. Transfer Characteristics

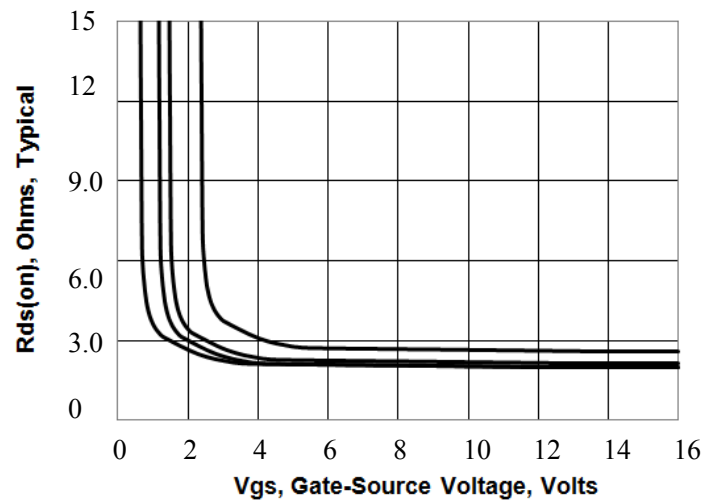


Figure 5. RDSONvs Gate Voltage

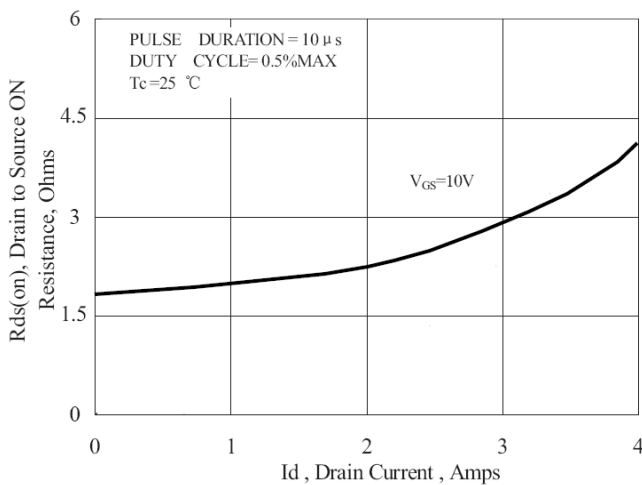


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

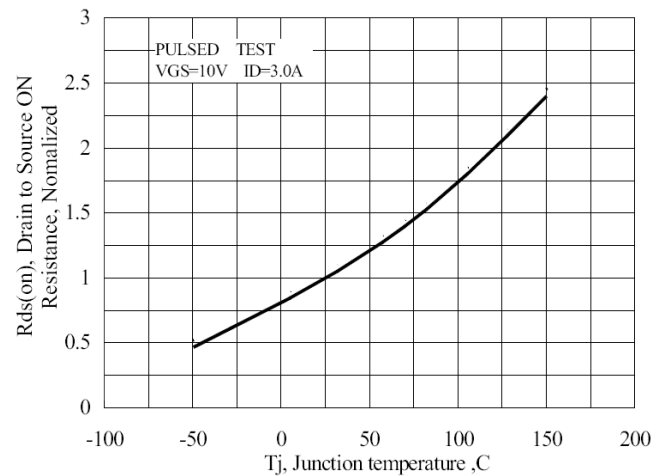


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

## Typical Characteristics(Cont.)

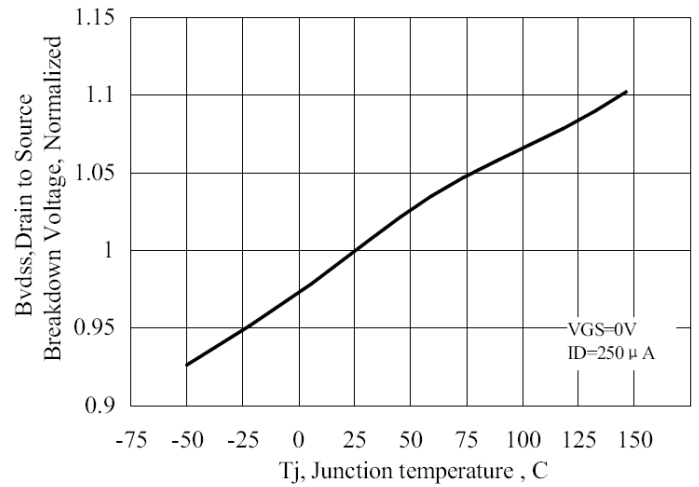
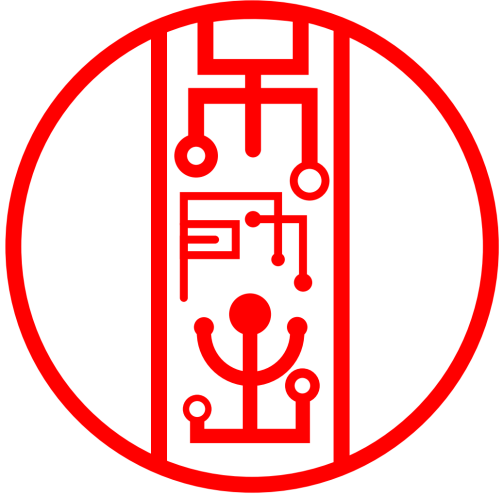


Figure 12 Typical Breakdown Voltage vs Junction Temperature

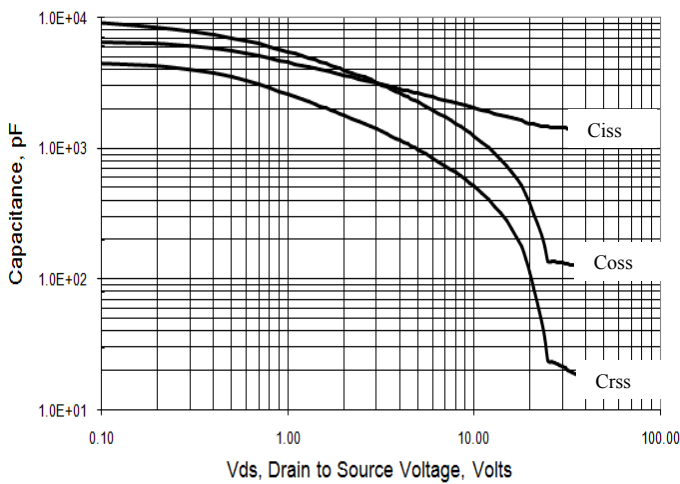


Figure 13. Capacitance vs Vds

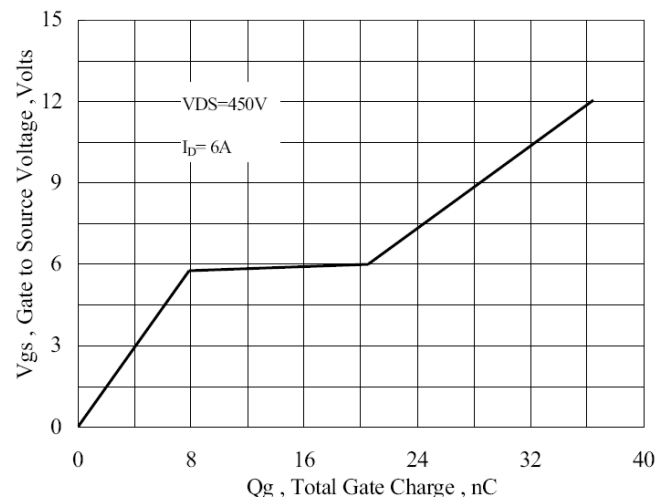


Figure 14 Typical Gate Charge vs Gate to Source Voltage

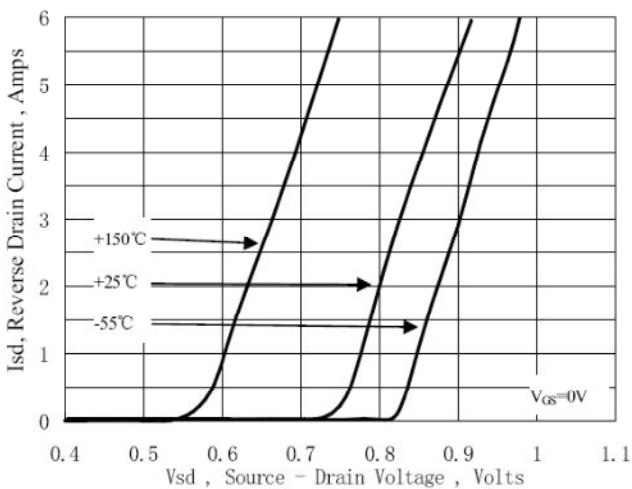


Figure 15 Typical Body Diode Transfer Characteristics

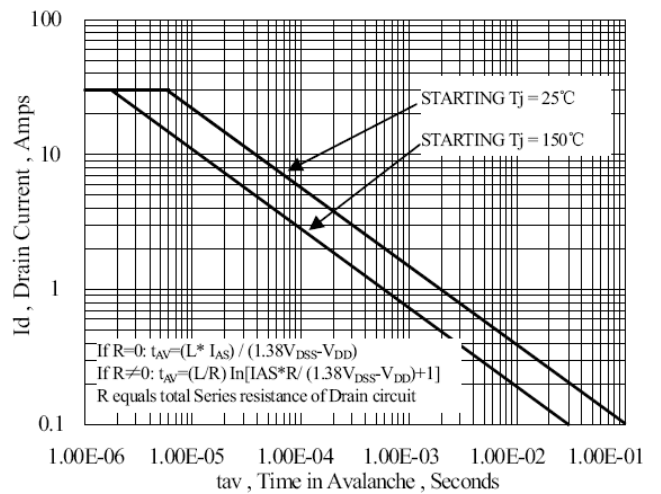


Figure 16 Unclamped Inductive Switching Capability

## Test Circuits and Waveforms

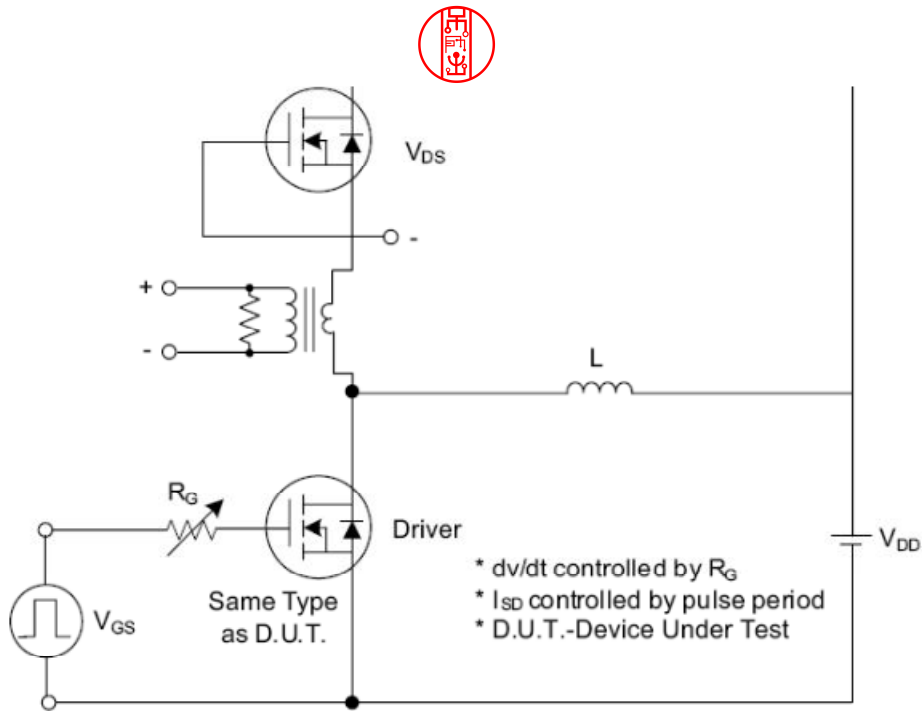


Fig. 1.1 Peak Diode Recovery  $dv/dt$  Test Circuit

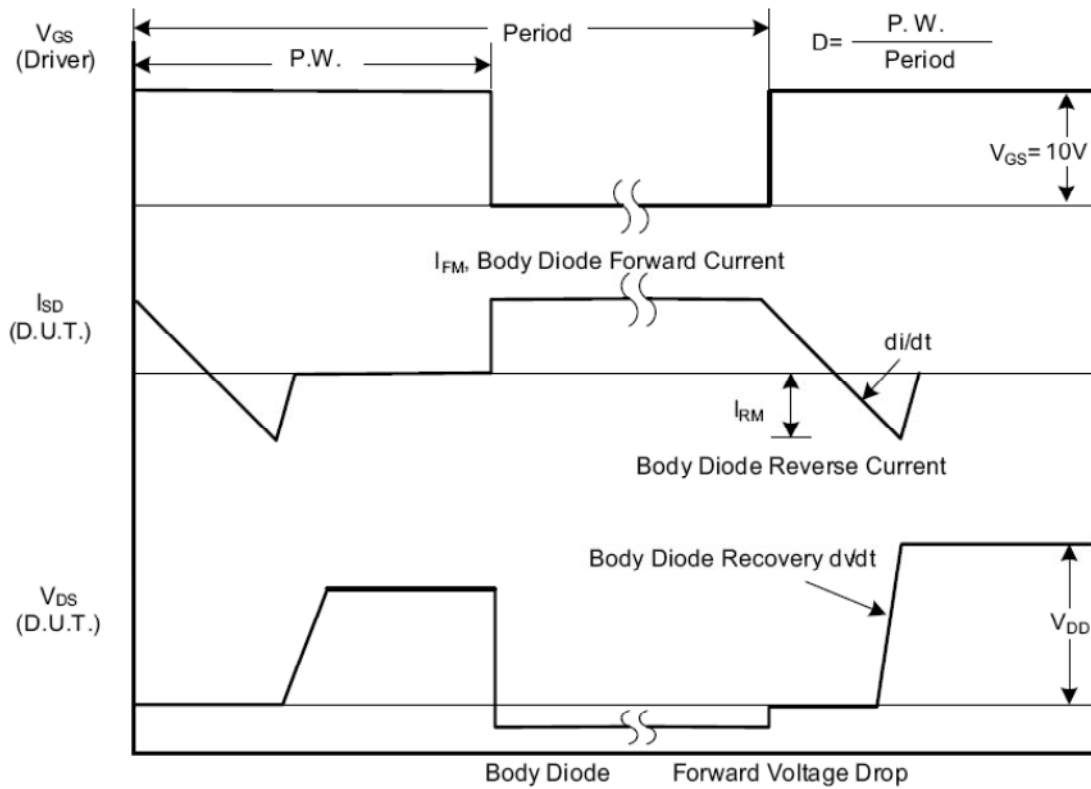


Fig. 1.2 Peak Diode Recovery  $dv/dt$  Waveforms

## Test Circuits and Waveforms (Cont.)

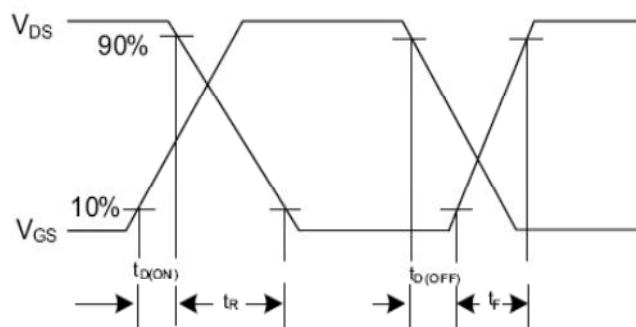
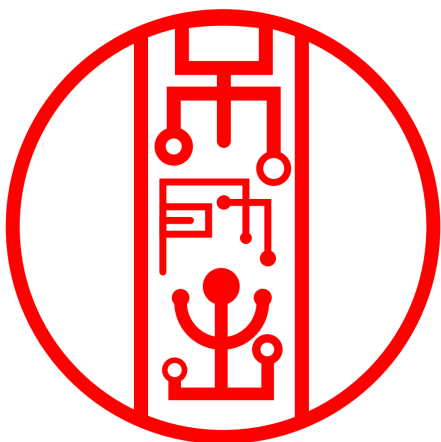


Fig. 2.2 Switching Waveforms

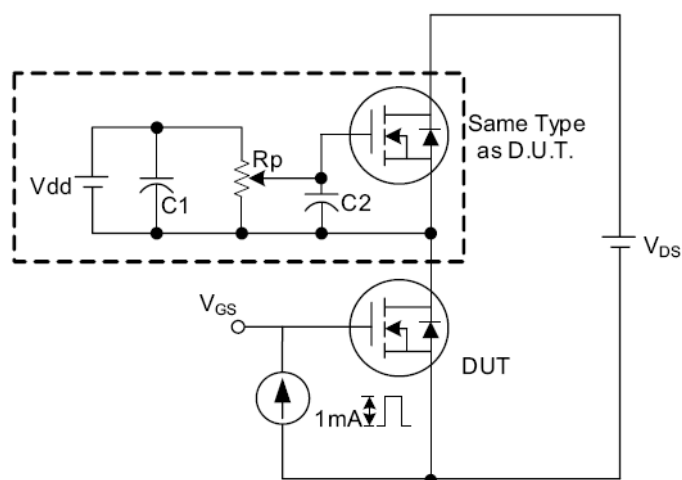


Fig. 3.1 Gate Charge Test Circuit

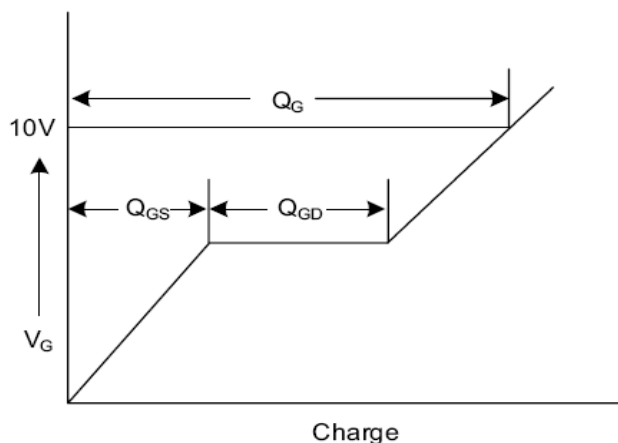


Fig. 3.2 Gate Charge Waveform

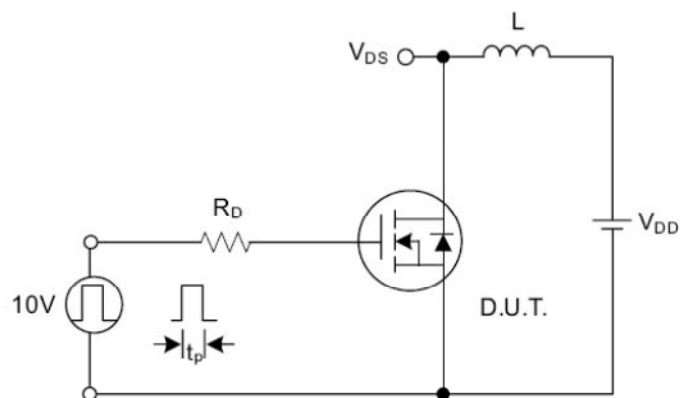


Fig. 4.1 Unclamped Inductive Switching Test Circuit

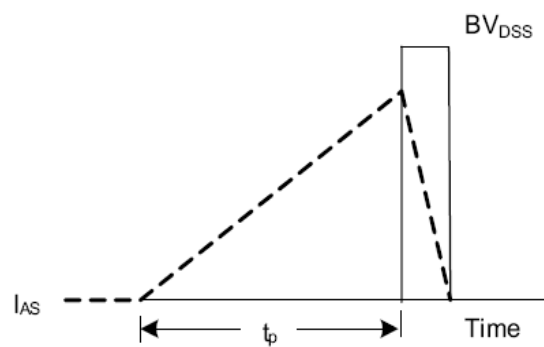


Fig. 4.2 Unclamped Inductive Switching Waveforms

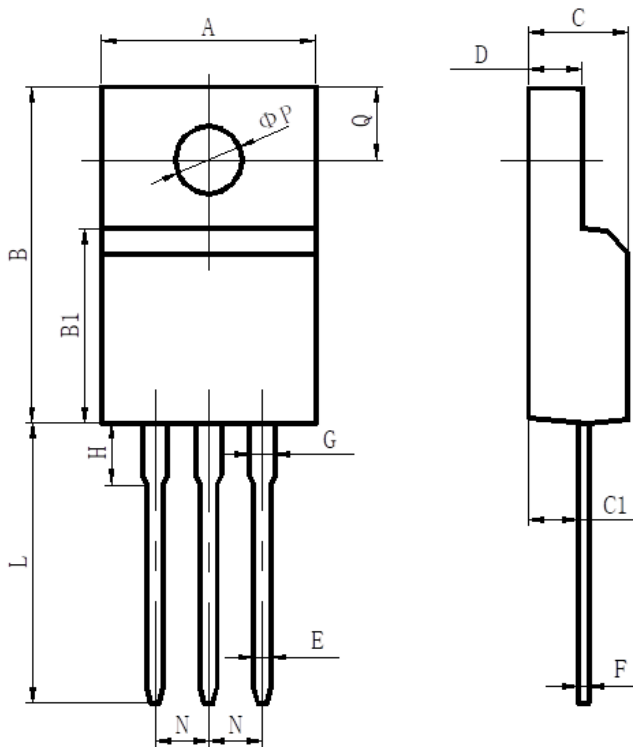




# SK04N100B-TF

## PACKAGE OUTLINE

TO-220F



|          | Unit (mm) |       |
|----------|-----------|-------|
|          | MIN       | MAX   |
| A        | 9.70      | 10.30 |
| B        | 15.50     | 16.10 |
| B1       | 8.99      | 9.39  |
| C        | 4.40      | 4.80  |
| C1       | 2.15      | 2.55  |
| D        | 2.50      | 2.90  |
| E        | 0.70      | 0.90  |
| F        | 0.40      | 0.60  |
| G        | 1.12      | 1.42  |
| H        | 3.40      | 3.80  |
| L        | 12.6      | 13.6  |
| N        | 2.34      | 2.74  |
| Q        | 3.15      | 3.55  |
| $\Phi P$ | 3.00      | 3.30  |